

Notice of References Cited	Application/Control No. 10/597,459	Applicant(s)/Patent Under Reexamination YAMAMOTO ET AL.	
	Examiner HENG M. CHAN	Art Unit 1793	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,509,892 A	05-1970	MACEK JOHN P	137/9
	B	US-			
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	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2002-372231	12-2002	JP	Tsuda et al.	
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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